74ACT11874 DUAL 4-BIT D-TYPE EDGE-TRIGGERED FLIP-FLOPS WITH 3-STATE OUTPUTS

SCAS212 - D3447, MARCH 1990 - REVISED APRIL 1993

| <ul> <li>Inputs Are TTL-Voltage Compatible</li> <li>3-State Buffer-Type Outputs Drive Bus</li> </ul> | DW PACKAGE<br>(TOP VIEW)   |  |  |  |  |  |
|--|----------------------------|--|--|--|--|--|
| Lines Directly   |                            |  |  |  |  |  |
| <ul> <li>Bus-Structured Pinout</li> </ul>  | 1Q1 2 27 11CLR             |  |  |  |  |  |
| <ul> <li>Asynchronous Clear</li> </ul>   | 1Q2 🛛 3 26 🗍 1D1           |  |  |  |  |  |
| • Flow-Through Architecture Optimizes  | 1Q3 🛛 4 25 🗋 1D2           |  |  |  |  |  |
| PCB Layout   | 1Q4 🛛 5 24 🖸 1D3           |  |  |  |  |  |
| Center-Pin V <sub>CC</sub> and GND Configurations  | GND 6 23 1D4               |  |  |  |  |  |
| Minimize High-Speed Switching Noise  | $GND$ 7 22 $V_{CC}$        |  |  |  |  |  |
| EPIC <sup>™</sup> (Enhanced-Performance Implanted  |                            |  |  |  |  |  |
| CMOS) 1-um Process   | GND 9 20 2D1               |  |  |  |  |  |
| <ul> <li>500-mA Typical Latch-Up Immunity</li> </ul>   | 2Q1 10 19 2D2              |  |  |  |  |  |
|  | 2Q2 0 11 18 2D3            |  |  |  |  |  |
| at 125°C   | 2Q3 🛛 12 🛛 17 🗍 2D4        |  |  |  |  |  |
| dependention   | 2Q4 [ 13 16 ] 2 <u>CLR</u> |  |  |  |  |  |
| description  | 2CLK [ 14 15 ] 2 <u>0E</u> |  |  |  |  |  |
| The 74ACT11874 contains dual 4-bit registers   |                            |  |  |  |  |  |

featuring 3-state outputs designed specifically for bus driving. This makes this device particularly suitable for implementing buffer registers, I/O ports, and working registers.

The D-type edge-triggered flip-flops enter data on the low-to-high transition of the clock. The 74ACT11874 has  $\overline{\text{CLR}}$  inputs and noninverting outputs. Taking  $\overline{\text{CLR}}$  low causes the four Q outputs to go low independently of the clock.

The 74ACT11874 is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.

|    | (each flip-flop) |            |   |                     |  |  |  |  |  |  |
|----|------------------|------------|---|---------------------|--|--|--|--|--|--|
|    | INP              | OUTPUT     |   |                     |  |  |  |  |  |  |
| OE | CLR              | CLK        | D | Q                   |  |  |  |  |  |  |
| L  | L                | Х          | Х | L                   |  |  |  |  |  |  |
| L  | Н                | $\uparrow$ | Н | Н                   |  |  |  |  |  |  |
| L  | Н                | $\uparrow$ | L | L                   |  |  |  |  |  |  |
| L  | Н                | L          | Х | Q <sub>0</sub><br>Z |  |  |  |  |  |  |
| н  | Х                | Х          | Х | Z                   |  |  |  |  |  |  |

FUNCTION TABLE

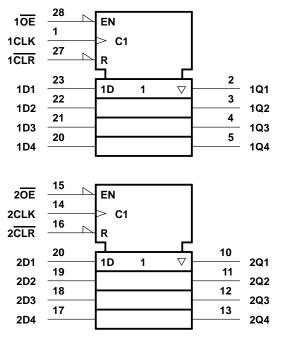
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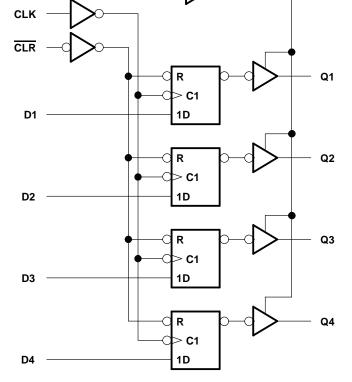


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### logic symbol<sup>†</sup>





logic diagram (each 4-bits) (positive logic)

### <sup>+</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

| Supply voltage range, V <sub>CC</sub>                          |                                   |
|--|-----------------------------------|
| Input voltage range, V <sub>I</sub> (see Note 1)               |                                   |
| Output voltage range, V <sub>O</sub> (see Note 1)              | -0.5 V to V <sub>CC</sub> + 0.5 V |
| Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ )  | ±20 mA                            |
| Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CC}$ ) | ±50 mA                            |
| Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$  | ±50 mA                            |
| Continuous current through V <sub>CC</sub> or GND              | ±200 mA                           |
| Storage temperature range                                      | – 55°C to 150°C                   |

OE

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



### recommended operating conditions

|                     |                                    | MIN  | MAX | UNIT |
|---------------------|------------------------------------|------|-----|------|
| VCC                 | Supply voltage                     | 4.5  | 5.5 | V    |
| VIH                 | High-level input voltage           | 2    |     | V    |
| VIL                 | Low-level input voltage            |      | 0.8 | V    |
| VI                  | Input voltage                      | 0    | VCC | V    |
| VO                  | Output voltage                     | 0    | VCC | V    |
| ЮН                  | High-level output current          |      | -24 | mA   |
| IOL                 | Low-level output current           |      | 24  | mA   |
| $\Delta t/\Delta v$ | Input transition rise or fall rate | 0    | 10  | ns/V |
| TA                  | Operating free-air temperature     | - 40 | 85  | °C   |

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER       | TEST CONDITIONS                                    | Vee   | Т    | T <sub>A</sub> = 25°C |       |      | мах  | UNIT |
|-----------------|--|-------|------|-----------------------|-------|------|------|------|
| PARAMETER       | TEST CONDITIONS                                    | Vcc   | MIN  | TYP                   | MAX   | MIN  | MAX  | UNIT |
|                 |  | 3 V   | 2.9  |                       |       | 2.9  |      |      |
|                 | I <sub>OH</sub> = - 50 μA                          | 4.5 V | 4.4  |                       |       | 4.4  |      |      |
|                 |  | 5.5 V | 5.4  |                       |       | 5.4  |      |      |
| VOH             | $I_{OH} = -4 \text{ mA}$                           | 3 V   | 2.58 |                       |       | 2.48 |      | V    |
|                 | I <sub>OH</sub> = – 24 mA                          | 4.5 V | 3.94 |                       |       | 3.8  |      |      |
|                 | 10H = -24  mz                                      | 5.5 V | 4.94 |                       |       | 4.8  |      |      |
|                 | $I_{OH} = -75 \text{ mA}^{\dagger}$                | 5.5 V |      |                       |       | 3.85 |      |      |
|                 | I <sub>OL</sub> = 50 μA                            | 3 V   |      |                       | 0.1   |      | 0.1  |      |
|                 |  | 4.5 V |      |                       | 0.1   |      | 0.1  |      |
|                 |  | 5.5 V |      |                       | 0.1   |      | 0.1  |      |
| VOL             | I <sub>OL</sub> = 12 mA                            | 3 V   |      |                       | 0.36  |      | 0.44 | V    |
|                 | I <sub>OL</sub> = 24 mA                            | 4.5 V |      |                       | 0.36  |      | 0.44 |      |
|                 |  | 5.5 V |      |                       | 0.36  |      | 0.44 |      |
|                 | $I_{OL} = 75 \text{ mA}^{\dagger}$                 | 5.5 V |      |                       |       |      | 1.65 |      |
| I <sub>OZ</sub> | $V_{O} = V_{CC} \text{ or } GND$                   | 5.5 V |      |                       | ± 0.5 |      | ± 5  | μA   |
| I               | $V_{I} = V_{CC}$ or GND                            | 5.5 V |      |                       | ± 0.1 |      | ± 1  | μA   |
| ICC             | $V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$ | 5.5 V |      |                       | 8     |      | 80   | μA   |
| Ci              | $V_{I} = V_{CC}$ or GND                            | 5 V   |      | 4                     |       |      |      | pF   |
| Co              | $V_{O} = V_{CC}$ or GND                            | 5 V   |      | 10                    |       |      |      | pF   |

<sup>†</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.



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# timing requirements over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

|                     |                                    |                 | T <sub>A</sub> = 25°C |     | ;   | MIN MA | МАХ | UNIT |
|---------------------|------------------------------------|-----------------|-----------------------|-----|-----|--------|-----|------|
|                     |                                    |                 | MIN                   | TYP | MAX |        | WAA | UNIT |
| fclock              | Clock frequency                    |                 | 0                     |     | 125 | 0      | 125 | MHz  |
| t <sub>w</sub>      | Pulse duration                     | CLR low         |                       | 2   |     | 4      |     |      |
|                     |                                    | CLK high or low |                       | 2   |     | 4      |     | ns   |
| t <sub>su</sub> Set | Setup time before CLK <sup>↑</sup> | Data            |                       | 1   |     | 5      |     |      |
|                     |                                    | CLR low         |                       | 2   |     | 2      |     | ns   |
| t <sub>h</sub>      | Hold time after CLK↑               | Data            |                       | 2   |     | 1      |     | ns   |

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

| PARAMETER        | FROM    | то                   | T <sub>A</sub> = 25°C |      |       | MIN  | МАХ  | UNIT |
|------------------|---------|----------------------|-----------------------|------|-------|------|------|------|
| FARAWETER        | (INPUT) | (OUTPUT) MIN TYP MAX |                       | WIIN | IVIAA | UNIT |      |      |
| f <sub>max</sub> |         |                      | 125                   |      |       | 125  |      | MHz  |
| <sup>t</sup> PLH | CLK     | Any O                |                       | 7.5  |       | 3.7  | 9.4  | 2    |
| <sup>t</sup> PHL | ULK     | Any Q                |                       | 8.1  |       | 4.1  | 10.6 | ns   |
| <sup>t</sup> PHL | CLR     | Any Q                |                       | 8.8  |       | 3.5  | 11.8 | ns   |
| <sup>t</sup> PZH | ŌĒ      | Amy O                |                       | 6.4  |       | 1.6  | 7.4  | ns   |
| <sup>t</sup> PZL | ÛE      | Any Q                |                       | 8.6  |       | 2.4  | 9.5  | 115  |
| <sup>t</sup> PHZ | ŌĒ      | Any O                |                       | 6.9  |       | 5.4  | 9.4  | ns   |
| <sup>t</sup> PLZ | UE      | Any Q                |                       | 6.8  |       | 4.9  | 9.1  | 115  |

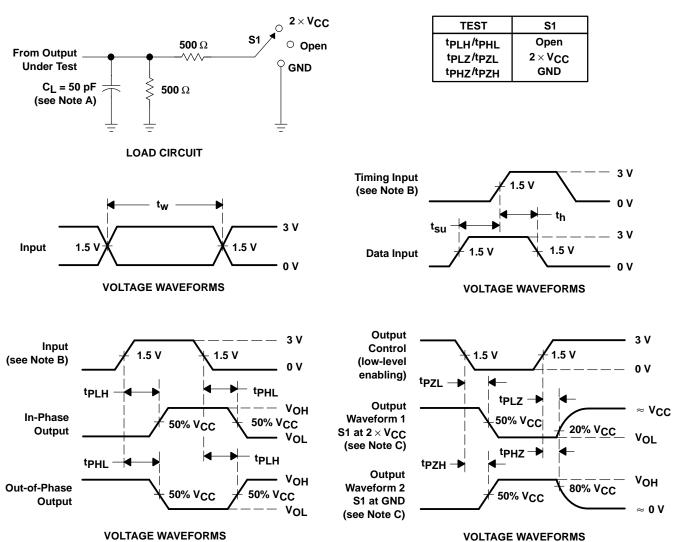
### operating characteristics, $V_{CC} = 5 V$ , $T_A = 25^{\circ}C$

| PARAMETER                                     |                  |  | TEST CONDITIONS | TYP | UNIT |
|---|------------------|--|-----------------|-----|------|
| C <sub>pd</sub> Power dissipation capacitance | Outputs enabled  |  | 76              | рF  |      |
|   | Outputs disabled | $C_{L} = 50 \text{ pF}, \text{ f} = 1 \text{ MHz}$ | 64              | μΓ  |      |



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WITH 3-STATE OUTPUTS SCAS212 – D3447, MARCH 1990 – REVISED APRIL 1993



### PARAMETER MEASUREMENT INFORMATION

NOTES: A. Cl includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>Q</sub> = 50  $\Omega$ , t<sub>r</sub> = 3 ns, t<sub>f</sub> = 3 ns.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
- Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. D. The outputs are measured one at a time with one input transition per measurement.

#### Figure 1. Load Circuit and Voltage Waveforms



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